

NEW Preview

Renewal of HIOKI's world-leading battery tester







Designing automatic battery testing systems is easier and faster than ever before

- Double the total line resistance, so measurement errors are less likely to occur when using long measurement cables
- Stable operation regardless of increased total line resistance due to probe and relay degradation
- LAN is equipped as a standard for easy system design and layout, and excellent noise resistance for stable operation

Lineup

| Application | | | Acceptance inspection of general-purpose, small cells installed in a high-speed sorters 3561, 3561-01 | Fully automated production line testing of small cells for power motors or small packs of up to 60 V BT3561A NEW AC four-terminal method | Fully automated production line testing of large cells for xEVs or mid-size packsup of to 100 V BT3562A NEW AC four-terminal method | Fully automated production line testing of large packs for xEVs or large packs up of to 300 V BT3563A NEW AC four-terminal method | | | | | | | |
|--|-------------|---|--|---|--|--|----------------------|----|------|---------------|---------------|---------------------------|---------------------------|
| Model | | | | | | | | | | | | | |
| Appearance Measurement method | | | | | | | | | | | | | |
| | | | | | | | Measurement frequenc | су | | 1 kHz ±0.2 Hz | 1 kHz ±0.2 Hz | 1 kHz ±0.2 Hz | 1 kHz ±0.2 Hz |
| | | | | | | | | | 3 mΩ | N/A | N/A | 3.1000 mΩ, 0.1 μΩ, 100 mA | 3.1000 mΩ, 0.1 μΩ, 100 m/ |
| De eletere e | ĺ | 30 mΩ | N/A | 31.000 mΩ, 1 μΩ, 100 mA | 31.000 mΩ, 1 μΩ, 100 mA | 31.000 mΩ, 1 μΩ, 100 mA | | | | | | | |
| Resistance measurement ranges | | 300 mΩ | 310.00 mΩ,10 μΩ, 10 mA | 310.00 mΩ,10 μΩ, 10 mA | 310.00 mΩ,10 μΩ, 10 mA | 310.00 mΩ,10 μΩ, 10 mA | | | | | | | |
| | | 3 Ω | 3.1000 Ω,100 μΩ, 1 mA | 3.1000 Ω,100 μΩ, 1 mA | 3.1000 Ω,100 μΩ, 1 mA | 3.1000 Ω,100 μΩ, 1 mA | | | | | | | |
| | | 30 Ω | N/A | 31.000 Ω, 1 mΩ, 100 μΑ | 31.000 Ω, 1 mΩ, 100 μΑ | 31.000 Ω, 1 mΩ, 100 μΑ | | | | | | | |
| Max. display, | | 300 Ω | N/A | 310.00 Ω, 10 mΩ, 10 μΑ | 310.00 Ω, 10 mΩ, 10 μΑ | 310.00 Ω, 10 mΩ, 10 μA | | | | | | | |
| resolution, measurement | | 3 kΩ | N/A | 3.1000 kΩ, 100 mΩ, 10 μΑ | 3.1000 kΩ, 100 mΩ, 10 μΑ | 3.1000 kΩ, 100 mΩ, 10 μA | | | | | | | |
| | | 3 mΩ range | N/A | N/A | | | | | | | | | |
| Bas | uracy | 30 mΩ range or more | ±0.5% rdg. ±5 dgt. | ±0.5% rdg. ±5 dgt. | ±0.5% rdg. ±10 dgt. | ±0.5% rdg. ±10 dgt. | | | | | | | |
| acc | uracy | | 0 0 | 6.00000 V,10 µV | ±0.5% rdg. ±5 dgt. | ±0.5% rdg. ±5 dgt. | | | | | | | |
| Voltage | 1 | 6 V | N/A 19.9999 V, 100 μV | ν/A | 6.00000 V,10 μV N/A | 6.00000 V, 10 μV N/A | | | | | | | |
| Bas acc Voltage measurement | | 60 V | | | | | | | | | | | |
| ranges | | | N/A | 60.0000 V, 100 μV | 60.0000 V, 100 μV | 60.0000 V, 100 μV | | | | | | | |
| | | 100 V | N/A | N/A | 100.000 V, 1 mV | N/A | | | | | | | |
| Max. display, | | 300 V | N/A | N/A | N/A | 300.000 V, 1 mV | | | | | | | |
| resolution | | 1000 V | N/A | N/A | N/A | N/A | | | | | | | |
| Basic accuracy | | ±0.01% rdg. ±3 dgt. *1 | ±0.01% rdg. ±3 dgt. | ±0.01% rdg. ±3 dgt. | ±0.01% rdg. ±3 dgt. | | | | | | | | |
| Response time *2 | | | 3 ms | 10 ms | 10 ms | 10 ms | | | | | | | |
| Sampling period "3 EX.FAST, FAST, MEDIUM, SLOW | | Ω or V | 4 ms, 12 ms, 35 ms, 150 ms | 4 ms, 12 ms, 35 ms, 150 ms | 4 ms, 12 ms, 35 ms, 150 ms | 4 ms, 12 ms, 35 ms, 150 m | | | | | | | |
| | | ΩV | 7 ms, 23 ms, 69 ms, 252 ms | 8 ms, 24 ms, 70 ms, 253 ms | 8 ms, 24 ms, 70 ms, 253 ms | 8 ms, 24 ms, 70 ms, 253 m | | | | | | | |
| Allowable total line resistance $^{'2}$ within accuracy) Ranges: 3 m Ω , 30 m Ω , 30 m Ω , 30 | | SENSE line | Ν/Α, Ν/Α, 20 Ω, 20 Ω | Ν/Α, 4 Ω, 30 Ω, 30 Ω | 4 Ω, 4 Ω, 30 Ω, 30 Ω | 4 Ω, 4 Ω, 30 Ω, 30 Ω | | | | | | | |
| | | SOURCE line | Ν/Α, Ν/Α, 20 Ω, 20 Ω | Ν/Α, 4 Ω, 20 Ω, 40 Ω | 4 Ω, 4 Ω, 20 Ω, 40 Ω | 4 Ω, 4 Ω, 20 Ω, 40 Ω | | | | | | | |
| Allowable total line resised error detection) | tance *2 *4 | SENSE line | Ν/Α, Ν/Α, 20 Ω, 20 Ω | Ν/Α, 6 Ω, 30 Ω, 30 Ω | 6 Ω, 6 Ω, 30 Ω, 30 Ω | 6 Ω, 6 Ω, 30 Ω, 30 Ω | | | | | | | |
| langes: 3 m Ω , 30 m Ω , 300 m Ω , 3 Ω | | SOURCE line | N/A, N/A, 20 Ω , 20 Ω | Ν/Α, 6 Ω, 20 Ω, 200 Ω | 6 Ω , 6 Ω , 20 Ω , 200 Ω | 6 Ω , 6 Ω , 20 Ω , 200 Ω | | | | | | | |
| Open terminal voltage Ranges: 30 m Ω , 3 Ω or more | | | N/A, 7 V, 7 V peak | 25 V, 7 V, 4 V peak | 25 V, 7 V, 4 V peak | 25 V, 7 V, 4 V peak | | | | | | | |
| LAN (TCP/IP, 10BASE-T/100BASE-TX) | | | N/A | V | V | V | | | | | | | |
| RS-232C *5 (Max. 38.4 kbps) | | | ✓ (9.6 kbps fixed) | ~ | V | V | | | | | | | |
| USB | | | N/A | N/A | N/A | N/A | | | | | | | |
| GP-IB | | ✓ (3561-01 Only) | N/A | N/A | N/A | | | | | | | | |
| EXT. I/O (37-pin Handler interface) | | | V | V | ✓ | ✓ | | | | | | | |
| Analog output (DC 0 V to 3.1 V) | | | N/A | V | V | V | | | | | | | |
| Contact check | | | V | V | V | ✓ | | | | | | | |
| Zero adjustment (±1000 counts) | | | V | V | V | V | | | | | | | |
| Pulse mesurement | | | V | V | ✓ | ✓ | | | | | | | |
| Comparator | | | Hi/ IN/ Lo | Hi/ IN/ Lo | Hi/ IN/ Lo | Hi/ IN/ Lo | | | | | | | |
| Statistical calculations Delay | | | Max. 30,000 | Max. 30,000 | Max. 30,000 | Max. 30,000 | | | | | | | |
| Delay | | | V | V | V | V | | | | | | | |
| Average | | | 2 to 16 times | 2 to 16 times | 2 to 16 times | 2 to 16 times | | | | | | | |
| Panel saving/loading | | | 126 | 126 | 126 | 126 | | | | | | | |
| Memory storage | | | 400 | 400 | 400 | 400 | | | | | | | |
| LabVIEW® driver *6 | | | N/A | ✓ | V | V | | | | | | | |
| Applicable standards | | | Safety: EN61010 EMC: EN61326 Class A | Safety: EN61010 EMC: EN61326 Class A | Safety: EN61010 EMC: EN61326 Class A | Safety: EN61010 EMC: EN61326 Class A | | | | | | | |
| Effect of radiated radio-frequency electromagnetic field (10 V/m) ⁷ | | | Resistant | Resistant | Resistant | Resistant | | | | | | | |
| electromagnetic field (1 Effect of conducted radi | | 10 V | N/A | Resistant | Resistant | Resistant | | | | | | | |
| requency electromagnetic field | | 3 V | Resistant | Resistant | Resistant | Resistant | | | | | | | |
| | | 7. 13 IVII 12 to 60 IVII 12, 60 /6 AIVI | | nesisiant | nesistant | Hesisiant | | | | | | | |
| | 0% AM | | · · · · · · · · · · · · · · · · · · · | ~ | V | V | | | | | | | |



^{*1:} rdg. stands for *reading*, dgt. stands for *digits* *2: Typical value *3: When the power supply frequency is 60 Hz *4: Total line resistance = wiring resistance + contact resistance + DUT resistance *5: Available as printer I/F *6: LabVIEW® Driver is a registered trademark of National Instruments Corporation *7: Test conditions were 80 MHz to 1 GHz at 10 V/m and 1 GHz to 6 GHz at 3 V/m, all at 80% AM *8: Canadian Standards Assosiation